

**Notice of References Cited**

Application/Control No.

10/578,666

Applicant(s)/Patent Under  
Reexamination  
TERANISHI ET AL.

Examiner

MICHAEL B. NELSON

Art Unit

1794

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,440,572	08-2002	Yokoyama et al.	428/447
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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	N	JP 05-185757	07-1993	JP	Kazuyoshi et al.	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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